

## Special Issue

# Advances in Imaging-Based NDT Methods

### Message from the Guest Editor

This Special Issue's focus is on the advancements of imaging based non-destructive testing and evaluation (NDT&E) methods for inspection of various metals, semiconductors, composites and biomaterials. The main focus is given to widely used non-destructive testing and evaluation methodologies and associated data processing schemes for inspection of various industrial and biomaterials. Topics of interest This Special Issue on NDT&E focuses on both laboratory and field applications, including but not limited to the following:

- Ultrasonic Testing
- Radiographic Testing
- Thermographic Testing
- Optical Testing
- Eddy Current Testing
- Magnetic Particle Inspection
- Liquid Penetrant Examination
- Signal/Image/Video Processing techniques for improving the sensitivity and resolution for visualization of surface/subsurface/volumetric defects.
- Non-destructive Testing/Non-invasive Inspection of Biomaterials
- Data fusion for NDT&E.

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### Guest Editor

Dr. Ravibabu Mulaveesala

Centre for Sensors, Instrumentation and Cyber Physical System  
Engineering (SeNSE) Indian Institute of Technology Delhi, New Delhi  
110016, India

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### Deadline for manuscript submissions

closed (30 July 2024)



## NDT

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# About the Journal

## Message from the Editor-in-Chief

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### Editor-in-Chief

Prof. Dr. Fabio Tosti

1. School of Computing and Engineering, University of West London, Room BY.03.19, St. Mary's Rd., Ealing, London W5 5RF, UK
  2. The Faringdon Centre for Non-Destructive Testing and Remote Sensing, University of West London, Room BY.GF.015, St. Mary's Rd., Ealing, London W5 5RF, UK
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